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	Application No.	Applicant(s)	<u> </u>
Notice of Allowability	09/669,664	NURISHI, RYUJI	
	Examiner	Art Unit	
	Deborah A. Raizen	2873	
The MAILING DATE of this communication app All claims being allowable, PROSECUTION ON THE MERITS IS nerewith (or previously mailed), a Notice of Allowance (PTOL-85 NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT F of the Office or upon petition by the applicant. See 37 CFR 1.31	S (OR REMAINS) CLOSED in (5) or other appropriate commur RIGHTS. This application is su	this application. If not included nication will be mailed in due co	urse. THIS
. $igotimes$ This communication is responsive to <u>Amendment of 9/3/2</u>	2004 and Supplemental Respo	nse of 9/27/2004.	
. ☑ The allowed claim(s) is/are <u>1-12 and 15-21</u> .			
. X The drawings filed on 26 September 2000 are accepted b	by the Examiner.		
<ul> <li>Acknowledgment is made of a claim for foreign priority to a)  All b)  Some* c)  None of the:</li> <li>1.  Certified copies of the priority documents have</li> <li>2.  Certified copies of the priority documents have</li> </ul>	ve been received.		
Copies of the certified copies of the priority decembers of the priority decembers.			n from the
International Bureau (PCT Rule 17.2(a)).	outmorks have been received	iii and haddhar diago appridatio	
* Certified copies not received:			
Applicant has THREE MONTHS FROM THE "MAILING DATE noted below. Failure to timely comply will result in ABANDON THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.		a reply complying with the requi	irements
A SUBSTITUTE OATH OR DECLARATION must be subminFORMAL PATENT APPLICATION (PTO-152) which gives			TICE OF
. CORRECTED DRAWINGS ( as "replacement sheets") mu	ust be submitted.		
(a)  including changes required by the Notice of Draftsper	rson's Patent Drawing Review	(PTO-948) attached	
1) 🗌 hereto or 2) 🔲 to Paper No./Mail Date	_·		
(b) ☐ including changes required by the attached Examine Paper No./Mail Date	r's Amendment / Comment or i	n the Office action of	
Identifying indicia such as the application number (see 37 CFR each sheet. Replacement sheet(s) should be labeled as such in			ack) of
On the deposit of and/or INFORMATION about the deposit attached Examiner's comment regarding REQUIREMENT			te the
Attachment(s) .  Notice of References Cited (PTO-892) .  Notice of Draftperson's Patent Drawing Review (PTO-948)	6. Interview Su		152)
		Mail Date	
. ☑ Information Disclosure Statements (PTO-1449 or PTO/SB	/08), 7. ☐ Examiner's A	anendmeno Comment	
<ul> <li>. ☑ Information Disclosure Statements (PTO-1449 or PTO/SB. Paper No./Mail Date 0304 (March 31, 04)</li> <li>. ☑ Examiner's Comment Regarding Requirement for Deposit</li> </ul>	_	Statement of Reasons for Allow	ance

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## **REASONS FOR ALLOWANCE**

1. Claims 1-12 and 15-21 are allowed.

The following is an examiner's statement of reasons for allowance:

In regard to claims 1-11, 15-17, 18/(15-17), and 19/18/(15-17), see previous Office actions.

The prior art taken either singularly or in combination fails to anticipate or fairly suggest the limitations of claim 12, in such a manner that a rejection under 35 U.S.C. 102 or 103 would be proper.

The prior art fails to teach a combination of all the features in claim 12. For example, these features include the detailed structure recited, especially the limitations that the first and second lens units are in order, that the second lens unit, which comprises an image-stabilizing means, has positive refractive power, and that the second lens unit is stationary during variation of magnification, and also the condition that the Abbe number of a negative lens is greater than the Abbe number of a positive lens in the image-stabilizing means by more than 10, in combination with all the other limitations of the claim.

For example, the zoom lens disclosed in Aoki (5,721,641, cited in IDS of 3/4/2004 and previously used to reject claim 12) does not meet the recited condition. The zoom lenses disclosed in published Japanese applications 11-237551 and 11-311742 (in Example 4, Table 19, the signs of r13 and r14 are interchanged, as can be seen from Fig. 4) also do not meet the recited condition. The zoom lenses disclosed in Hamano et al. (6,473,231), especially examples 7-9, also do not meet the recited condition: although the third lens group has a negative lens and a positive lens that meet the recited condition, the positive lens that has low Abbe number and the

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negative lens that has high Abbe number are not in the subunit that is shifted. Hayakawa (6,384975) discloses lenses that appear to meet the recited condition, but the lenses are not zoom lenses and lens group L2 (the first lens unit as recited in claim 12) is arranged to move only for focusing and not during variation of magnification.

Claims 18/12, 19/18/12, 20, and 21 depend on claim 12 and are therefore allowed as well.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

## Conclusion

2. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Deborah A. Raizen, Ph.D., J.D., whose telephone number is (571) 272-2336. The examiner can normally be reached on Monday-Friday, from 10:00 a.m. to 3:00 p.m. Eastern Standard Time (a part-time schedule).

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Georgia Y. Epps can be reached at (571) 272-2328. The USPTO central official fax number is (703) 872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. For more information about the PAIR system, see http://pair-direct.uspto.gov. For access to the Private PAIR system, contact the

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Electronic Business Center (EBC) at 866-217-9197 (toll-free) or at 703-305-3028 or at 703-308-

6845, or by e-mail at: ebc@uspto.gov. Additional information is available on the Patent EBC

Web site at: <a href="http://www.uspto.gov/ebc/index.html">http://www.uspto.gov/ebc/index.html</a>.

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Scott J. Sugarman Primary Examiner